# DATA SHEET WWW.DZSC.COM 74ABT861 10-bit bus transceiver (3-State)

INTEGRATED CIRCUITS

Product specification Supersedes data of 1995 Sep 06 IC23 Data Handbook

1998 Jan 16







# 74ABT861

### **FEATURES**

- Provides high performance bus interface buffering for wide data/address paths or buses carrying parity
- Buffered control inputs for light loading, or increased fan-in as required with MOS microprocessors
- Output capability: +64mA/–32mA
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model
- Power-up 3-State
- Inputs are disabled during 3-State mode

QUICK REFERENCE DATA

### DESCRIPTION

The 74ABT861 bus transceiver provides high performance bus interface buffering for wide data/address paths of buses carrying parity.

The 74ABT861 10-bit bus transceiver has NOR-ed transmit and receive output enables for maximum control flexibility.

SYMBOL	PARAMETER	CONDITIONS T <sub>amb</sub> = 25°C; GND = 0V	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay An to Bn or Bn to An	$C_{L} = 50 pF; V_{CC} = 5V$	3.4	ns
C <sub>IN</sub>	Input capacitance	$V_I = 0V \text{ or } V_{CC}$	4	pF
C <sub>I/O</sub>	I/O capacitance	Outputs disabled; $V_{O} = 0V$ or $V_{CC}$	7	pF
I <sub>CCZ</sub>	Total supply current	Outputs disabled; V <sub>CC</sub> =5.5V	500	nA

# **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
24-Pin Plastic DIP	–40°C to +85°C	74ABT861 N	74ABT861 N	SOT222-1
24-Pin plastic SO	–40°C to +85°C	74ABT861 D	74ABT861 D	SOT137-1
24-Pin Plastic SSOP Type II	–40°C to +85°C	74ABT861 DB	74ABT861 DB	SOT340-1
24-Pin Plastic TSSOP Type I	–40°C to +85°C	74ABT861 PW	74ABT861PW DH	SOT355-1

# **PIN CONFIGURATION**

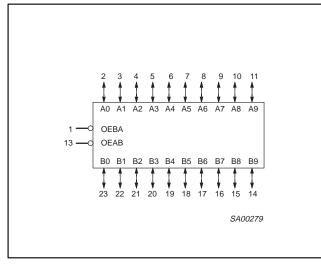
OEBA 1		24 V <sub>CC</sub>
A0 2		23 ВО
A1 3		22 B1
A2 4		21 B2
A3 5		20 ВЗ
A4 6	TOP VIEW	19 B4
A5 7	IOF VILW	18 B5
A6 8		17 B6
A7 9		16 B7
A8 10		15 B8
A9 11		14 B9
GND 12		13 OEAB
L		SA00278

# **PIN DESCRIPTION**

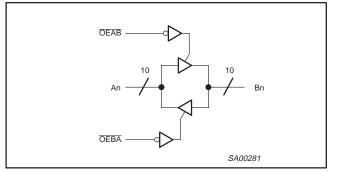
PIN NUMBER	SYMBOL	FUNCTION
13	OEAB	A side to B side output enable input (active-Low)
2, 3, 4, 5, 6, 7, 8, 9, 10, 11	A0-A9	Data inputs/outputs (A side)
23, 22, 21, 20, 19, 18, 17, 16, 15, 14	B0-B9	Data inputs/outputs (B side)
1	OEBA	B side to A side output enable input (active-Low)
12	GND	Ground (0V)
24	V <sub>CC</sub>	Positive supply voltage

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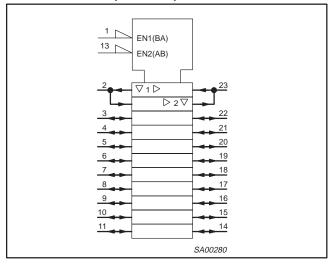
### LOGIC SYMBOL



# LOGIC DIAGRAM



# LOGIC SYMBOL (IEEE/IEC)



# **FUNCTION TABLE**

INP	JTS	OPERATING			
OEAB	OEBA	MODE			
L	Н	A data to B bus			
Н	L	B data to A bus			
Н	Н	Z			

H = High voltage level

L = Low voltage level Don't care

X Z =

High impedance "off" state =

### **ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-18	mA
VI	DC input voltage <sup>3</sup>		-1.2 to +7.0	V
I <sub>ОК</sub>	DC output diode current	V <sub>O</sub> < 0	-50	mA
V <sub>OUT</sub>	DC output voltage <sup>3</sup>	output in Off or High state	-0.5 to +5.5	V
I <sub>OUT</sub>	DC output current	output in Low state	128	mA
T <sub>stg</sub>	Storage temperature range		-65 to 150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIMITS		UNIT
		Min	Max	
V <sub>CC</sub>	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V <sub>CC</sub>	V
V <sub>IH</sub>	High-level input voltage	2.0		V
V <sub>IL</sub>	Low-level input voltage		0.8	V
I <sub>ОН</sub>	High-level output current		-32	mA
I <sub>OL</sub>	Low-level output current		64	mA
Δt/Δv	Input transition rise or fall rate	0	5	ns/V
T <sub>amb</sub>	Operating free-air temperature range	-40	+85	°C

# DC ELECTRICAL CHARACTERISTICS

						LIMITS			
SYMBOL	PARAM	IETER	TEST CONDITIONS	Ta	<sub>mb</sub> = +25	i°C	T <sub>amb</sub> = −40°C to +85°C		
				Min	Тур	Max	Min	Max	1
V <sub>IK</sub>	Input clamp vo	ltage	$V_{CC} = 4.5V; I_{IK} = -18mA$		-0.9	-1.2		-1.2	V
			$V_{CC}$ = 4.5V; $I_{OH}$ = -3mA; $V_I$ = $V_{IL}$ or $V_{IH}$	2.5	3.5		2.5		V
V <sub>OH</sub>	High-level output voltage		$V_{CC}$ = 5.0V; $I_{OH}$ = -3mA; $V_I$ = $V_{IL}$ or $V_{IH}$	3.0	4.0		3.0		V
			$V_{CC}$ = 4.5V; $I_{OH}$ = -32mA; $V_I$ = $V_{IL}$ or $V_{IH}$	2.0	2.6		2.0		V
V <sub>OL</sub>	Low-level outp	out voltage	$V_{CC}$ = 4.5V; $I_{OL}$ = 64mA; $V_I$ = $V_{IL}$ or $V_{IH}$		0.42	0.55		0.55	V
l	Input leakage	Control pins	$V_{CC} = 5.5V; V_1 = GND \text{ or } 5.5V$		±0.01	±1.0		±1.0	μA
	current	Data pins	$V_{CC} = 5.5V$ ; $V_I = GND$ or 5.5V		±5.0	±100		±100	μA
I <sub>OFF</sub>	Power-off leakage current		$V_{CC}$ = 0.0V; $V_{O}$ or $V_{I} \le 4.5V$		±5.0	±100		±100	μΑ
I <sub>PU/PD</sub>	Power–up/down 3-State output current <sup>3</sup>		$V_{CC} = 2.1V; V_O = 0.5V; V_I = GND \text{ or } V_{CC};$ $V_{OE} = V_{CC}$		±5.0	±50		±50	μΑ
I <sub>IH</sub> + I <sub>OZH</sub>	3-State output	High current	$V_{CC}$ = 5.5V; $V_{O}$ = 2.7V; $V_{I}$ = $V_{IL}$ or $V_{IH}$		5.0	50		50	μΑ
I <sub>IL</sub> + I <sub>OZL</sub>	3-State output	Low current	$V_{CC}$ = 5.5V; $V_{O}$ = 0.5V; $V_{I}$ = $V_{IL}$ or $V_{IH}$		-5.0	-50		-50	μΑ
I <sub>CEX</sub>	Output high lea	akage current	$V_{CC}$ = 5.5V; $V_{O}$ = 5.5V; $V_{I}$ = GND or $V_{CC}$		5.0	50		50	μΑ
Ι <sub>Ο</sub>	Output current	1	$V_{CC} = 5.5V; V_{O} = 2.5V$	-50	-100	-180	-50	-180	mA
I <sub>CCH</sub>			$V_{CC}$ = 5.5V; Outputs High, $V_{I}$ = GND or $V_{CC}$		0.5	250		250	μΑ
I <sub>CCL</sub>	Quiescent sup	ply current	$V_{CC}$ = 5.5V; Outputs Low, $V_{I}$ = GND or $V_{CC}$		25	38		38	mA
I <sub>CCZ</sub>			$V_{CC}$ = 5.5V; Outputs 3-State; V <sub>I</sub> = GND or V <sub>CC</sub>		0.5	50		50	μΑ
			Outputs enabled, one input at 3.4V, other inputs at V <sub>CC</sub> or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA
$\Delta I_{CC}$	Additional supp input pin <sup>2</sup>	bly current per	Outputs 3-State, one data input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5V$		0.01	50		50	μΑ
			Outputs 3-State, one enable input at 3.4V, other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA

# NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

This is the increase in supply current for each input at 3.4V.
This parameter is valid for any V<sub>CC</sub> between 0V and 2.1V with a transition time of up to 10msec. For V<sub>CC</sub> = 2.1V to V<sub>CC</sub> = 5V ± 10%, a transition time of up to 100µsec is permitted.

# 74ABT861

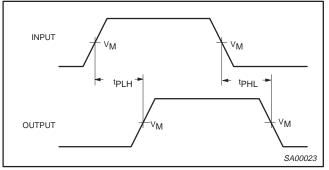
### **AC CHARACTERISTICS**

GND = 0V,  $t_R$  =  $t_F$  = 2.5ns,  $C_L$  = 50pF,  $R_L$  = 500 $\Omega$ 

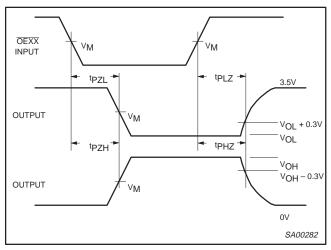
					LIMITS			
SYMBOL	PARAMETER	WAVEFORM	ŗ	a <sub>mb</sub> = +25° V <sub>CC</sub> = +5.0V	C /		= -40 to 5°C .0V ±0.5V	UNIT
			Min	Тур	Max	Min	Мах	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay An to Bn or Bn to An	1	1.1 1.0	3.4 3.2	4.9 4.9	1.1 1.0	5.2 5.2	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output enable time to High and Low level	2	1.2 2.4	3.5 4.6	5.0 6.0	1.2 2.4	5.9 6.9	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output disable time from High and Low level	2	3.1 3.7	5.3 5.3	6.5 6.6	3.1 3.7	7.5 7.1	ns

# AC WAVEFORMS

 $V_{M}$  = 1.5V,  $V_{IN}$  = GND to 3.0V

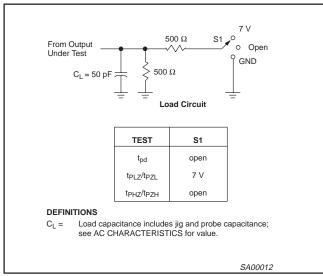


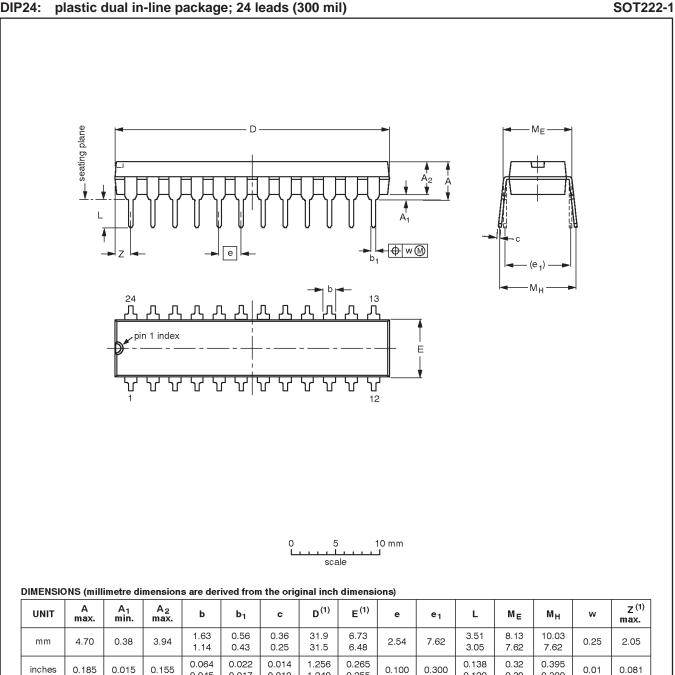
Waveform 1. Input to Output Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

### **TEST CIRCUIT AND WAVEFORM**





### DIP24: plastic dual in-line package; 24 leads (300 mil)

10-bit bus transceiver (3-State)

### Note

1. Plastic or metal protrusions of 0.01 inches maximum per side are not included.

0.045

0.017

0.010

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1550E DATE
SOT222-1		MS-001AF			95-03-11

0.255

0.120

0.30

0.300

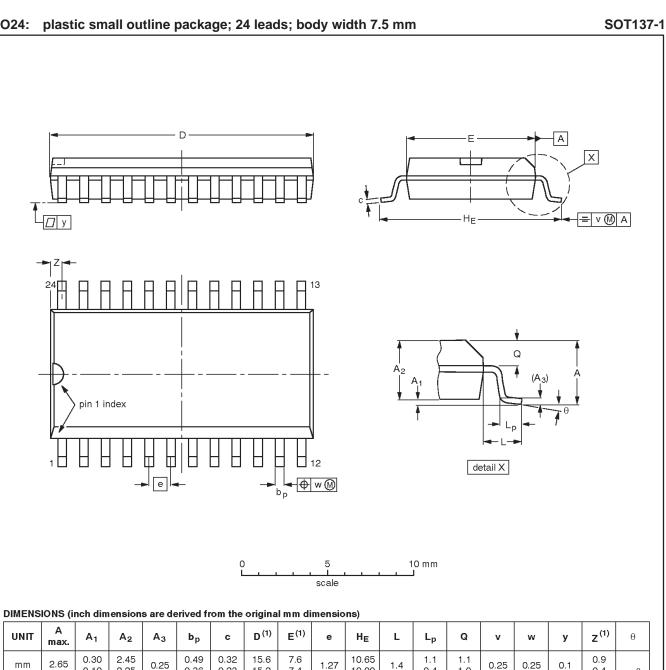
1.240

0.4

0.035 0.016

8° 00

# 10-bit bus transceiver (3-State)



### SO24:

### Note

inches

0.10

0.012

0.004

0.10

2.25

0.096

0.089

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

0.01

0.23

0.013

0.009

15.2

0.61

0.60

0.36

0.019

0.014

VERSION IEC JEDEC EIAJ PROJECTION	OUTLINE		REFEF	RENCES	EUROPEAN		
	VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SO  137-1   O75-05   MS-01300	SOT137-1	075E05	MS-013AD			<del>-95-01-24</del> 97-05-22	

0.050

7.4

0.30

0.29

1.4

0.055

0.4

0.043

0.016

1.0

0.043

0.039

0.01

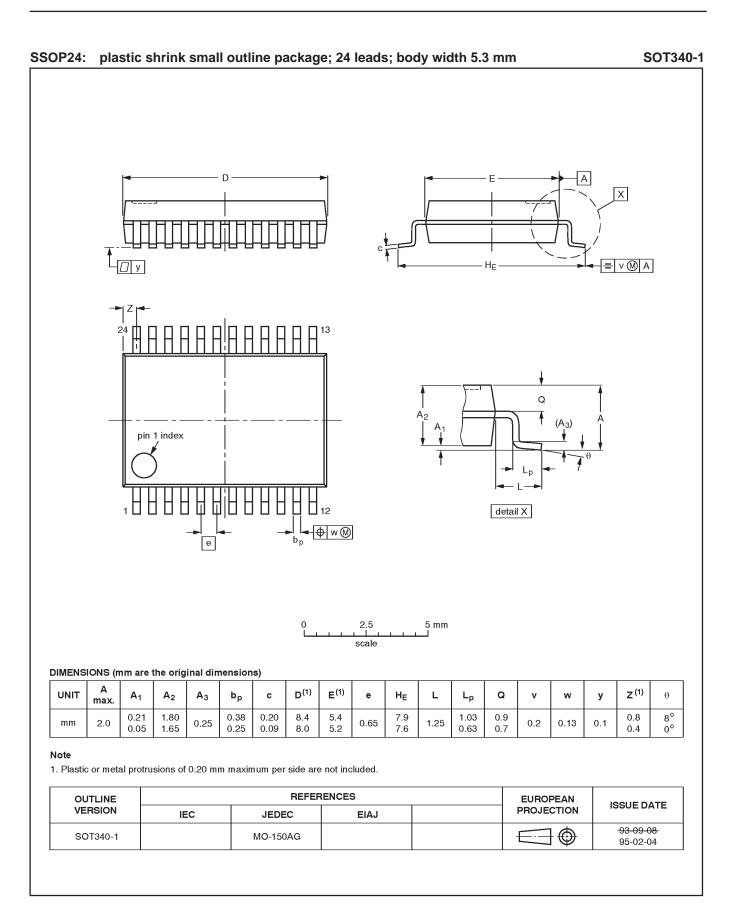
0.01

0.004

10.00

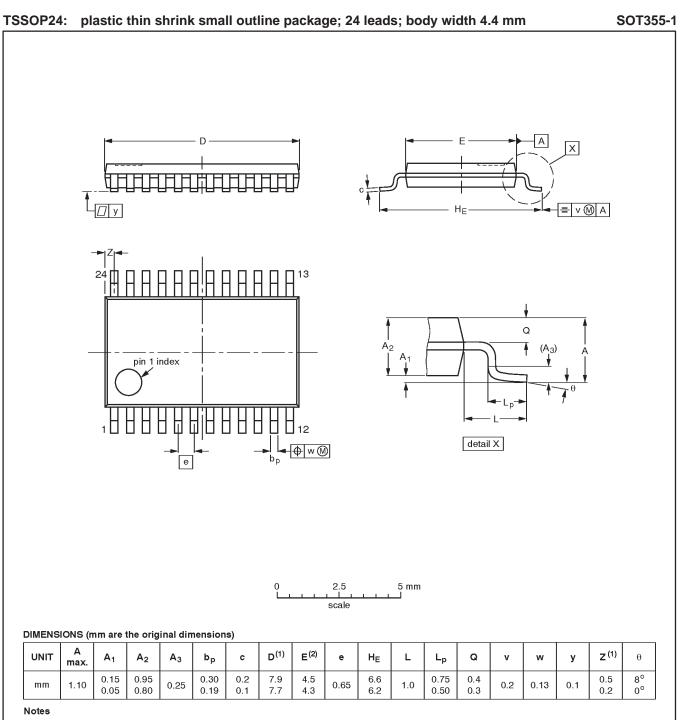
0.419

0.394



# 10-bit bus transceiver (3-State)

# 10-bit bus transceiver (3-State)



1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT355-1		MO-153AD			<del>- 93-06-16-</del> 95-02-04

### Data sheet status

Data sheet status	Product status	Definition <sup>[1]</sup>
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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